PD - 91555A

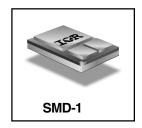
International **ICR** Rectifier **POWER MOSFET SURFACE MOUNT (SMD-1)**

Product Summary

| Part Number | RDS(on) | ID |
|-------------|---------|------|
| IRFNG40 | 3.5Ω | 3.9A |

HEXFET® MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.

IRFNG40 1000V, N-CHANNEL HEXFET[®] MOSFET TECHNOLOGY



Features:

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Dynamic dv/dt Rating
- Surface mount
- Light-weight

| | Parameter | | Units | |
|--|--------------------------------------|--------------------|-------|--|
| ID @ VGS = 10V, TC = 25°C | Continuous Drain Current | 3.9 | | |
| ID @ VGS = 10V, TC = 100°C | Continuous Drain Current | 2.5 | A | |
| IDM | Pulsed Drain Current 1 | 15.6 | 6 | |
| P _D @ T _C = 25°C | Max. Power Dissipation | 125 | W | |
| | Linear Derating Factor | 1.0 | W/°C | |
| VGS Gate-to-Source Voltage | | ±20 | V | |
| EAS | EAS Single Pulse Avalanche Energy 2 | | mJ | |
| IAR | Avalanche Current ① | 3.9 | A | |
| EAR Repetitive Avalanche Energy ① | | 12.5 | mJ | |
| dv/dt Peak Diode Recovery dv/dt 3 | | 1.0 | V/ns | |
| Тј | Operating Junction | -55 to 150 | | |
| TSTG | Storage Temperature Range | | °C | |
| | Package Mounting Surface Temperature | 300(for 5 seconds) | | |
| | Weight | 2.6 (Typical) | g | |
| | | | | |

Absolute Maximum Ratings

For footnotes refer to the last page

International **ISR** Rectifier

| | Parameter | Min | Тур | Max | Units | Test Conditions |
|---------------------------------|--|------|------|------|----------|--|
| BVDSS | Drain-to-Source Breakdown Voltage | 1000 | - | — | V | $V_{GS} = 0V, I_{D} = 1.0mA$ |
| ∆BV _{DSS} /∆TJ | Temperature Coefficient of Breakdown Voltage | _ | 1.4 | _ | V/°C | Reference to 25°C, ID = 1.0mA |
| RDS(on) | Static Drain-to-Source On-State | — | — | 3.5 | Ω | VGS = 10V, ID = 2.5A |
| | Resistance | — | — | 4.2 | <u> </u> | VGS = 10V, ID = 3.9A |
| VGS(th) | Gate Threshold Voltage | 2.0 | — | 4.0 | V | $V_{DS} = V_{GS}$, $I_D = 250 \mu A$ |
| 9fs | Forward Transconductance | 3.3 | — | — | S (უ) | V _{DS} > 15V, I _{DS} = 2.5A ④ |
| IDSS | Zero Gate Voltage Drain Current | — | — | 25 | | V _{DS} = 800V ,V _{GS} =0V |
| | | — | - | 250 | μΑ | $V_{DS} = 800V,$ |
| | | | | | | $V_{GS} = 0V, T_{J} = 125^{\circ}C$ |
| IGSS | Gate-to-Source Leakage Forward | — | — | 100 | | $V_{GS} = 20V$ |
| IGSS | Gate-to-Source Leakage Reverse | — | — | -100 | nA | $V_{GS} = -20V$ |
| Qg | Total Gate Charge | — | — | 120 | | VGS =10V, ID =3.9A |
| Qgs | Gate-to-Source Charge | — | — | 12 | nC | $V_{DS} = 500V$ |
| Qgd | Gate-to-Drain ('Miller') Charge | — | — | 66 | | |
| ^t d(on) | Turn-On Delay Time | — | — | 30 | | $V_{DD} = 500V, I_D = 3.9A,$ |
| tr | Rise Time | | — | 50 | | $V_{GS} = 10V, R_G = 9.1\Omega$ |
| ^t d(off) | Turn-Off Delay Time | — | _ | 170 | ns | |
| tf | Fall Time | — | — | 50 | | |
| L _S + L _D | Total Inductance | _ | 4.0 | — | nH | Measured from the center of drain pad to center of source pad. |
| C _{iss} | Input Capacitance | _ | 1700 | — | | $V_{GS} = 0V, V_{DS} = 25V$ |
| C _{OSS} | Output Capacitance | | 250 | — | pF | f = 1.0MHz |
| C _{rss} | Reverse Transfer Capacitance | _ | 100 | — | | |

Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

Source-Drain Diode Ratings and Characteristics

| | Parameter | | Min | Тур | Max | Units | Test Conditions |
|-----|----------------------------------|---|-----|-----|------|-------|---------------------------------------|
| IS | Continuous Source Current (Body | Diode) | _ | _ | 3.9 | Α | |
| ISM | Pulse Source Current (Body Diode |) 1 | Ι | _ | 15.6 | | |
| VSD | Diode Forward Voltage | | - | _ | 1.8 | V | Tj = 25°C, IS = 3.9A, VGS = 0V ④ |
| trr | Reverse Recovery Time | | Ι | _ | 1000 | nS | Tj = 25°C, Iϝ = 3.9A, di/dt ≤ 100A/μs |
| QRR | Reverse Recovery Charge | | — | _ | 5.6 | μC | V _{DD} ≤ 50V ④ |
| ton | Forward Turn-On Time Intrins | Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by LS + LD. | | | | | |

Thermal Resistance

| | Parameter | Min | Тур | Max | Units | Test Conditions |
|-------|------------------|-----|-----|-----|-------|-----------------|
| RthJC | Junction-to-Case | - | — | 1.0 | °C/W | |

For footnotes refer to the last page

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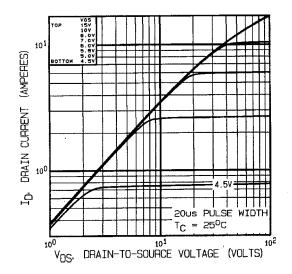


Fig 1. Typical Output Characteristics

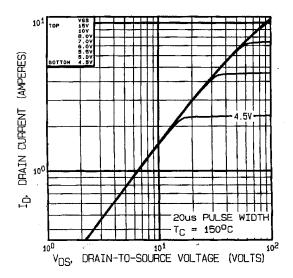


Fig 2. Typical Output Characteristics

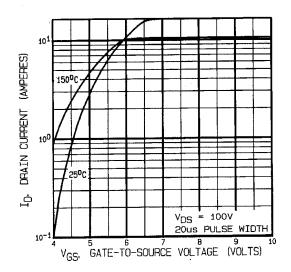


Fig 3. Typical Transfer Characteristics

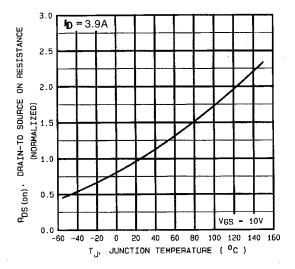


Fig 4. Normalized On-Resistance Vs. Temperature

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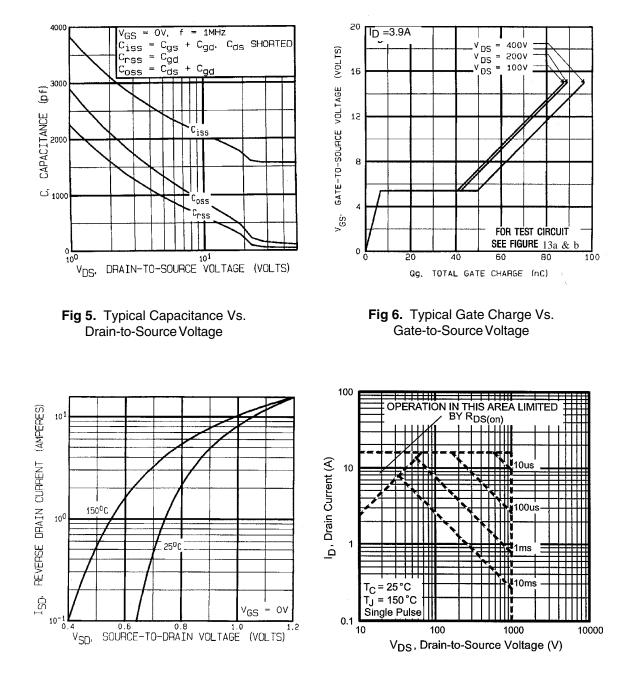
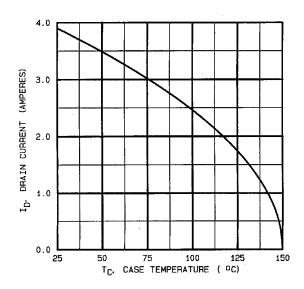
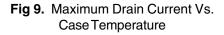


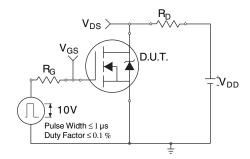
Fig 7. Typical Source-Drain Diode Forward Voltage

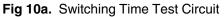
Fig 8. Maximum Safe Operating Area

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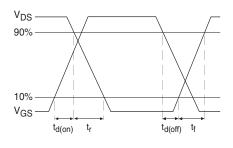


Fig 10b. Switching Time Waveforms

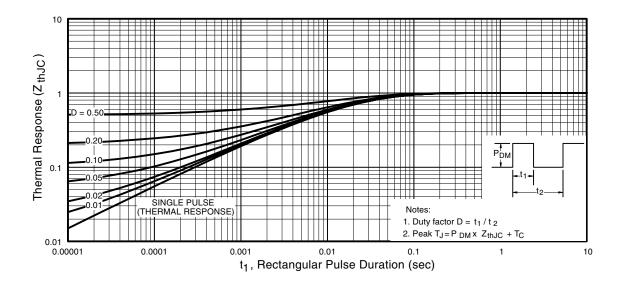


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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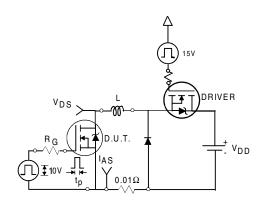


Fig 12a. Unclamped Inductive Test Circuit

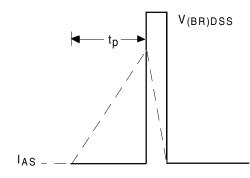


Fig 12b. Unclamped Inductive Waveforms

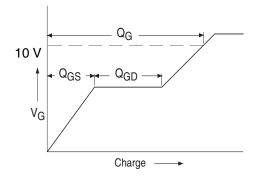


Fig 13a. Basic Gate Charge Waveform

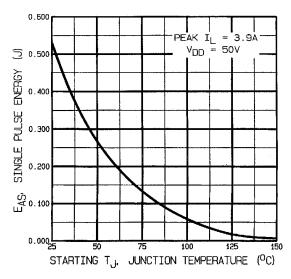


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

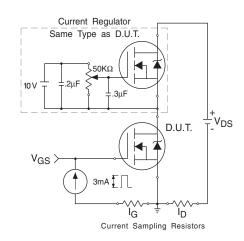


Fig 13b. Gate Charge Test Circuit

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Footnotes:

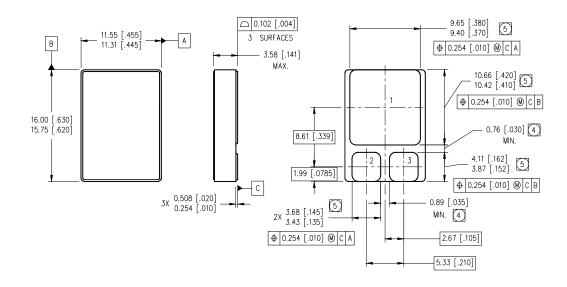
- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- $@~V_{DD}$ = 50V, starting TJ = 25°C, L= 69mH Peak IL = 3.9A, V_{GS} = 10V
- ④ Pulse width \leq 300 μ s; Duty Cycle \leq 2%

PAD ASSIGNMENTS

1- DRAIN

2- GATE

3- SOURCE



Case Outline and Dimensions — SMD-1

NOTES:

- 1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
- 2. CONTROLLING DIMENSION: INCH.
- 3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 4 DIMENSION INCLUDES METALLIZATION FLASH.
- 5 DIMENSION DOES NOT INCLUDE METALLIZATION FLASH.

International **IGR** Rectifier

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